Se	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/616,097	SUN ET AL.
Examiner	· Art Unit
Edna Wong	1753

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Class	Subclass	Date	Examiner
205	118	6/1/2005	EW
205	123	6/1/2005	EW
205	182	6/1/2005	EW
205	296	6/1/2005	EW

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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Inventor Search	6/1/2005	EW
EAST	6/1/2005	EW
STN	6/1/2005	EW
Search Updated	9/24/2005	EW